

AMIC

A420616 Series

Preliminary

1M X 16 CMOS DYNAMIC RAM WITH EDO PAGE MODE

Document Title

1M X 16 CMOS DYNAMIC RAM WITH EDO PAGE MODE

Revision History

<u>Rev. No.</u>	<u>History</u>	<u>Issue Date</u>	<u>Remark</u>
0.0	Initial issue	June 23, 1999	Preliminary
0.1	Modify AC, DC data	February 7, 2002	
0.2	Modify DC data and all parts guarantee self-refresh mode	June 10, 2002	



A420616 Series

Preliminary

1M X 16 CMOS DYNAMIC RAM WITH EDO PAGE MODE

Features

- Organization: 1,048,576 words X 16 bits
- Part Identification
 - A420616 (1K Ref.)
- Single 5.0V power supply/built-in VBB generator
- Low power consumption
 - Operating: 120mA (-45 max)
 - Standby: 1.0mA (TTL), 1.0mA (CMOS)
1.5mA (Self-refresh current)
- High speed
 - 45/50 ns $\overline{\text{RAS}}$ access time
 - 20/22 ns column address access time
 - 12/13 ns $\overline{\text{CAS}}$ access time
 - 18/20 ns EDO Page Mode Cycle Time
- Industrial operating temperature range: -40°C to 85°C for -U
- Fast Page Mode with Extended Data Out
- Separate $\overline{\text{CAS}}$ ($\overline{\text{UCAS}}$, $\overline{\text{LCAS}}$) for byte selection
- 1K Refresh Cycle in 16ms
- Read-modify-write, $\overline{\text{RAS}}$ -only, $\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$, Hidden refresh capability
- TTL-compatible, three-state I/O
- JEDEC standard packages
 - 400mil, 42-pin SOJ
 - 400mil, 44/50 TSOP type II package

General Description

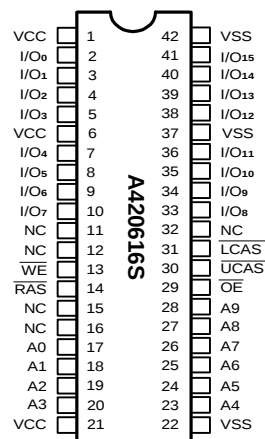
The A420616 is a new generation randomly accessed memory for graphics, organized in a 1,048,576-word by 16-bit configuration. This product can execute Byte Write and Byte Read operation via two $\overline{\text{CAS}}$ pins.

The A420616 offers an accelerated Fast Page Mode

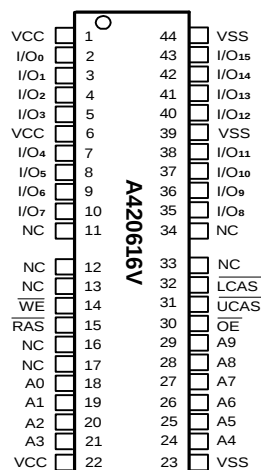
This allow random access of up to 1024 words within a row at a 56/50 MHz EDO cycle, making the A420616 ideally suited for graphics, digital signal processing and high performance computing systems.

Pin Configuration

■ SOJ



■ TSOP



Pin Descriptions

Symbol	Description
A0 – A9	Address Inputs
I/O ₀ - I/O ₁₅	Data Input/Output
$\overline{\text{RAS}}$	Row Address Strobe
$\overline{\text{LCAS}}$	Column Address Strobe for Lower Byte (I/O ₀ – I/O ₇)
$\overline{\text{UCAS}}$	Column Address Strobe for Upper Byte (I/O ₈ – I/O ₁₅)
$\overline{\text{WE}}$	Write Enable
$\overline{\text{OE}}$	Output Enable
VCC	5.0V Power Supply
VSS	Ground
NC	No Connection

cycle with a feature called Extended Data Out (EDO).

**Selection Guide**

Symbol	Description	-45	-50	Unit
t _{RAC}	Maximum $\overline{\text{RAS}}$ Access Time	45	50	ns
t _{AA}	Maximum Column Address Access Time	20	22	ns
t _{CAC}	Maximum $\overline{\text{CAS}}$ Access Time	12	13	ns
t _{OEa}	Maximum Output Enable ($\overline{\text{OE}}$) Access Time	12	13	ns
t _{RC}	Minimum Read or Write Cycle Time	76	84	ns
t _{PC}	Minimum EDO Cycle Time	18	20	ns

Functional Description

The A420616 reads and writes data by multiplexing an 20-bit address into a 10-bit row and 10-bit column address. $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ are used to strobe the row address and the column address, respectively.

The A420616 has two $\overline{\text{CAS}}$ inputs: $\overline{\text{LCAS}}$ controls I/O₀-I/O₇, and $\overline{\text{UCAS}}$ controls I/O₈-I/O₁₅. $\overline{\text{UCAS}}$ and $\overline{\text{LCAS}}$ function in an identical manner to $\overline{\text{CAS}}$ in that either will generate an internal $\overline{\text{CAS}}$ signal. The $\overline{\text{CAS}}$ function and timing are determined by the first $\overline{\text{CAS}}$ ($\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$) to transition low and by the last to transition high. Byte Read and Byte Write are controlled by using $\overline{\text{LCAS}}$ and $\overline{\text{UCAS}}$ separately.

A Read cycle is performed by holding the $\overline{\text{WE}}$ signal high during $\overline{\text{RAS}}/\overline{\text{CAS}}$ operation. A Write cycle is executed by holding the $\overline{\text{WE}}$ signal low during $\overline{\text{RAS}}/\overline{\text{CAS}}$ operation; the input data is latched by the falling edge of $\overline{\text{WE}}$ or $\overline{\text{CAS}}$, whichever occurs later. The data inputs and outputs are routed through 16 common I/O pins, with $\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$ and $\overline{\text{OE}}$ controlling the in direction.

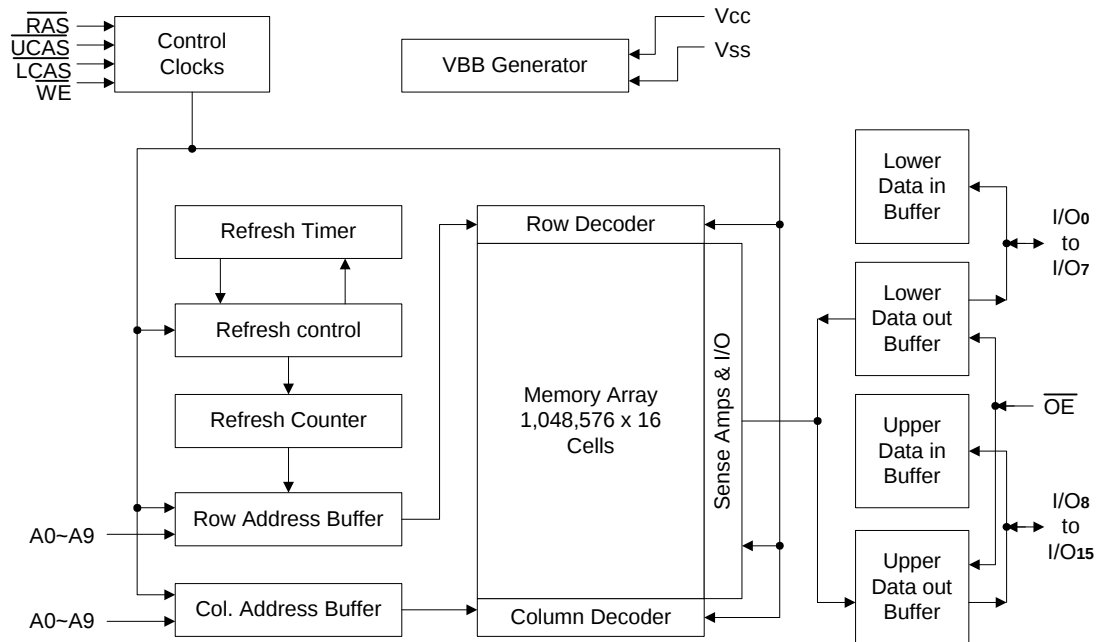
EDO Page Mode operation all 1024(1K) columns within a selected row to be randomly accessed at a high data rate. A EDO Page Mode cycle is initiated with a row address latched by $\overline{\text{RAS}}$ followed by a column address latched by $\overline{\text{CAS}}$. While holding $\overline{\text{RAS}}$ low, $\overline{\text{CAS}}$ can be toggled to strobe changing column addresses, thus achieving shorter cycle times.

The A420616 offers an accelerated Fast Page Mode cycle through a feature called Extended Data Out, which keeps the output drivers on during the $\overline{\text{CAS}}$ precharge time (t_{cp}). Since data can be output after $\overline{\text{CAS}}$ goes high, the user is not required to wait for valid data to appear before starting the next access cycle. Data-out will remain valid as long as $\overline{\text{RAS}}$ and $\overline{\text{OE}}$ are low, and $\overline{\text{WE}}$ is high; this is the only characteristic which differentiates Extended Data Out operation from a standard Read or Fast Page Read.

A memory cycle is terminated by returning both $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ high. Memory cell data will retain its correct state by maintaining power and accessing all 1024(1K) combinations of the 10-bit row addresses, regardless of sequence, at least once every 16ms through any $\overline{\text{RAS}}$ cycle (Read, Write) or $\overline{\text{RAS}}$ Refresh cycle ($\overline{\text{RAS}}$ -only, CBR, or Hidden). The CBR Refresh cycle automatically controls the row addresses by invoking the refresh counter and controller.

Power-On

The initial application of the VCC supply requires a 200 μs wait followed by a minimum of any eight initialization cycles containing a $\overline{\text{RAS}}$ clock. During Power-On, the VCC current is dependent on the input levels of $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$. It is recommended that $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ track with VCC or be held at a valid V_{ih} during Power-On to avoid current surges.

**Block Diagram****Recommended Operating Conditions** ($T_a = 0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$ or -40°C to $+85^{\circ}\text{C}$)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
VCC	Power Supply	4.5	5.0	5.5	V	1
VSS	Input High Voltage	0.0	0.0	0.0	V	1
V _{IH}	Input High Voltage	2.4	-	VCC + 1.0	V	1
V _{IL}	Input Low Voltage	-0.5	-	0.8	V	1

Truth Table

Function	$\overline{\text{RAS}}$	$\overline{\text{UCAS}}$	$\overline{\text{LCAS}}$	$\overline{\text{WE}}$	$\overline{\text{OE}}$	Address	I/Os	Notes
Standby	H	H	H	X	X	X	High-Z	
Read: Word	L	L	L	H	L	Row/Col.	Data Out	
Read: Lower Byte	L	H	L	H	L	Row/Col.	I/O ₀₋₇ = Data Out I/O ₈₋₁₅ = High-Z	
Read: Upper Byte	L	L	H	H	L	Row/Col.	I/O ₀₋₇ = High-Z I/O ₈₋₁₅ = Data Out	
Write: Word	L	L	L	L	H	Row/Col.	Data In	
Write: Lower Byte	L	H	L	L	H	Row/Col.	I/O ₀₋₇ = Data In I/O ₈₋₁₅ = X	
Write: Upper Byte	L	L	H	L	H	Row/Col.	I/O ₀₋₇ = X I/O ₈₋₁₅ = Data In	
Read-Write	L	L	L	H→L	L→H	Row/Col.	Data Out → Data In	1,2
EDO-Page-Mode Read: Hi-Z								
-First cycle	L	H→L	H→L	H	H→L	Row/Col.	Data Out	2
-Subsequent Cycles	L	H→L	H→L	H	H→L	Col.	Data Out	2
EDO-Page-Mode Write								
-First cycle	L	H→L	H→L	L	H	Row/Col.	Data In	1
-Subsequent Cycles	L	H→L	H→L	L	H	Col.	Data In	1
EDO-Page-Mode Read-Write								
-First cycle	L	H→L	H→L	H→L	L→H	Row/Col.	Data Out → Data In	1, 2
-Subsequent Cycles	L	H→L	H→L	H→L	L→H	Col.	Data Out → Data In	1, 2
Hidden Refresh Read	L→H→L	L	L	H	L	Row/Col.	Data Out	2
Hidden Refresh Write	L→H→L	L	L	L	X	Row/Col.	Data In → High-Z	1
$\overline{\text{RAS}}$ -Only Refresh	L	H	H	X	X	Row	High-Z	
CBR Refresh	H→L	L	L	X	X	X	High-Z	3
Self Refresh	H→L	L	L	H	X	X	High-Z	

Note:

1. Byte Write may be executed with either $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$ active.
2. Byte Read may be executed with either $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$ active.
3. Only one $\overline{\text{CAS}}$ signal ($\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$) must be active.

**Absolute Maximum Ratings***

Input Voltage (Vin) -1.0V to +7.0V
Output Voltage (Vout) -1.0V to +7.0V
Power Supply Voltage (VCC) -1.0V to +7.0V
Operating Temperature (T_{OPR}) 0°C to +70°C
Storage Temperature (T_{STG}) -55°C to +150°C
Soldering Temperature X Time (T_{SOLDER})
260°C X 10sec
Power Dissipation (P_D) 1W
Short Circuit Output Current (I_{OUT}) 50mA
Latch-up Current 200mA

***Comments**

Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to this device. These are stress ratings only. Functional operation of this device at these or any other conditions above those indicated in the operational sections of these specification is not implied or intended. Exposure to the absolute maximum rating conditions for extended periods may affect device reliability.

DC Electrical Characteristics (VCC = 5.0V ± 10%, VSS = 0V, Ta = 0°C to +70°C or -40°C to +85°C)

Symbol	Parameter	-45		-50		Unit	Test Conditions	Notes
		Min.	Max.	Min.	Max.			
I _{IL}	Input Leakage Current	-5	+5	-5	+5	μA	0V ≤ Vin ≤ VCC Pins not under Test = 0V	
I _{OL}	Output Leakage Current	-5	+5	-5	+5	μA	D _{OUT} disabled, 0V ≤ Vout ≤ VCC	
I _{CC1}	Operating Power Supply Current	-	120	-	115	mA	$\overline{\text{RAS}}$, $\overline{\text{UCAS}}$, $\overline{\text{LCAS}}$ and Address cycling; t _{RC} = min.	1, 2
I _{CC2}	TTL Supply Current Supply Current	-	1.0	-	1.0	mA	$\overline{\text{RAS}} = \overline{\text{UCAS}} = \overline{\text{LCAS}} = V_{IH}$	
I _{CC3}	Average Power Supply Current, $\overline{\text{RAS}}$ Refresh Mode	-	120	-	115	mA	$\overline{\text{RAS}}$ and Address cycling, $\overline{\text{UCAS}} = \overline{\text{LCAS}} = V_{IH}$, t _{RC} = min.	1
I _{CC4}	EDO Page Mode Average Power Supply Current	-	120	-	115	mA	$\overline{\text{RAS}}$ and address = V _{IL} , $\overline{\text{UCAS}}$, $\overline{\text{LCAS}}$ and Address cycling; t _{PC} = min.	1, 2
I _{CC5}	$\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$ Refresh Power Supply Current	-	120	-	115	mA	$\overline{\text{RAS}}$ and $\overline{\text{UCAS}}$ or $\overline{\text{LCAS}}$ cycling; t _{RC} = min.	1
I _{CC6}	CMOS Standby Power Supply Current	-	1.0	-	1.0	mA	$\overline{\text{RAS}} = \overline{\text{UCAS}} = \overline{\text{LCAS}} =$ VCC - 0.2V	
I _{CC7}	Self Refresh Mode Current	-	1.5	-	1.5	mA	$\overline{\text{RAS}} = \overline{\text{CAS}} \leq V_{SS} + 0.2V$ All other input high levels are VCC-0.2V or input low levels are VSS +0.2V	
V _{OH}	Output Voltage	2.4	-	2.4	-	V	I _{OUT} = -5.0mA	
V _{OL}		-	0.4	-	0.4	V	I _{OUT} = 4.2mA	



A420616 Series

AC Characteristics (VCC = 5.0V $\pm$ 10%, VSS = 0V, Ta = 0°C to +70°C or -40°C to +85°C)

Test Conditions:

Input timing reference level: V_{IH}/V_{IL}=2.4V/0.8V

Output reference level: V_{OH}/V_{OL}=2.0V/0.8V

Output Load: 2TTL gate + CL (50pF)

Assumed tr=2ns

#	Std Symbol	Parameter	-45		-50		Unit	Notes
			Min.	Max.	Min.	Max.		
	t _r	Transition Time (Rise and Fall)	1	50	1	50	ns	4, 5
1	t _{RC}	Random Read or Write Cycle Time	76	-	84	-	ns	
2	t _{RP}	$\overline{\text{RAS}}$ Precharge Time	27	-	30	-	ns	
3	t _{RAS}	$\overline{\text{RAS}}$ Pulse Width	45	10K	50	10K	ns	
4	t _{CAS}	$\overline{\text{CAS}}$ Pulse Width	7	10K	8	10K	ns	
5	t _{RCD}	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Delay Time	10	33	11	37	ns	6
6	t _{RAD}	$\overline{\text{RAS}}$ to Column Address Delay Time	8	25	9	28	ns	7
7	t _{RSH}	$\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ Hold Time	7	-	8	-	ns	
8	t _{CSH}	$\overline{\text{CAS}}$ Hold Time	35	-	37	-	ns	
9	t _{CRP}	$\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ Precharge Time	5	-	5	-	ns	
10	t _{ASR}	Row Address Setup Time	0	-	0	-	ns	
11	t _{RAH}	Row Address Hold Time	7	-	8	-	ns	
12	t _{CLZ}	$\overline{\text{CAS}}$ to Output in Low Z	3	-	3	-	ns	8
13	t _{RAC}	Access Time from $\overline{\text{RAS}}$	-	45	-	50	ns	6,7
14	t _{CAC}	Access Time from $\overline{\text{CAS}}$	-	12	-	13	ns	6, 13
15	t _{AA}	Access Time from Column Address	-	20	-	22	ns	7, 13
16	t _{OE}	$\overline{\text{OE}}$ Access Time	-	12	-	13	ns	
17	t _{AR}	Column Address Hold Time from $\overline{\text{RAS}}$	40	-	45	-	ns	
18	t _{RCS}	Read Command Setup Time	0	-	0	-	ns	
19	t _{RCH}	Read Command Hold Time	0	-	0	-	ns	9



AC Characteristics (continued) (VCC = 5.0V ± 10%, VSS = 0V, Ta = 0°C to +70°C or -40°C to +85°C)

Test Conditions:

Input timing reference level: VIH/VIL=2.4V/0.8V

Output reference level: VOH/VOL=2.0V/0.8V

Output Load: 2TTL gate + CL (50pF)

Assumed tr=2ns

#	Std Symbol	Parameter	-45		-50		Unit	Notes
			Min.	Max.	Min.	Max.		
20	tRRH	Read Command Hold Time Reference to $\overline{\text{RAS}}$	0	-	0	-	ns	9
21	tRAL	Column Address to $\overline{\text{RAS}}$ Lead Time	20	-	22	-	ns	
22	tCOH	Output Hold After $\overline{\text{CAS}}$ Low	2	-	3	-	ns	
23	tOFF	Output Buffer Turn-Off Delay Time	-	2	-	3	ns	8, 10
24	tASC	Column Address Setup Time	0	-	0	-	ns	
25	tCAH	Column Address Hold Time	7	-	8	-	ns	
26	tOES	$\overline{\text{OE}}$ Low to $\overline{\text{CAS}}$ High Set Up	10	-	10	-	ns	
27	twCS	Write Command Setup Time	0	-	0	-	ns	11
28	twCH	Write Command Hold Time	7	-	8	-	ns	11
29	twCR	Write Command Hold Time to $\overline{\text{RAS}}$	40	-	45	-	ns	
30	tWP	Write Command Pulse Width	7	-	8	-	ns	
31	trWL	Write Command to $\overline{\text{RAS}}$ Lead Time	12	-	13	-	ns	
32	tcWL	Write Command to $\overline{\text{CAS}}$ Lead Time	7	-	8	-	ns	
33	tDS	Data-in setup Time	0	-	0	-	ns	12
34	tDH	Data-in Hold Time	7	-	8	-	ns	12
35	tDHR	Data-in Hold Time to $\overline{\text{RAS}}$	40	-	45	-	ns	
36	trWC	Read-Modify-Write Cycle Time	104	-	114	-	ns	
37	trWD	$\overline{\text{RAS}}$ to $\overline{\text{WE}}$ Delay Time (Read-Modify-Write)	59	-	65	-	ns	11
38	tcWD	$\overline{\text{CAS}}$ to $\overline{\text{WE}}$ Delay Time (Read-Modify-Write)	26	-	28	-	ns	11

**AC Characteristics (continued)** (VCC = 5.0V ± 10%, VSS = 0V, Ta = 0°C to +70°C or -40°C to +85°C)

Test Conditions:

Input timing reference level: V_{IH}/V_{IL}=2.4V/0.8VOutput reference level: V_{OH}/V_{OL}=2.0V/0.8V

Output Load: 2TTL gate + CL (50pF)

Assumed t_r=2ns

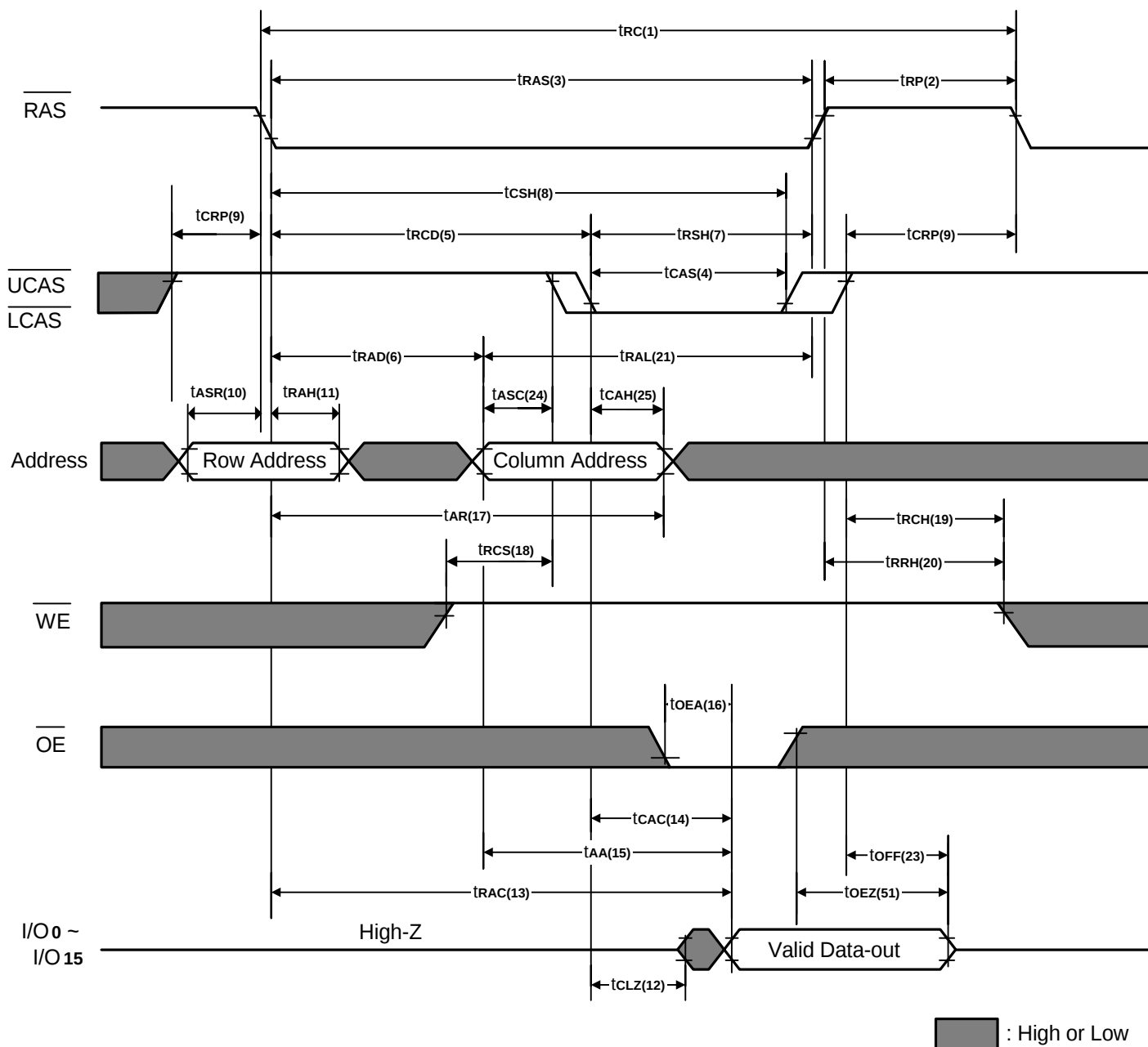
#	Std Symbol	Parameter	-45		-50		Unit	Notes
			Min.	Max.	Min.	Max.		
39	t _{AWD}	Column Address to $\overline{\text{WE}}$ Delay Time (Read-Modify-Write)	34	-	37	-	ns	11
40	t _{OE$\overline{\text{H}}$}	$\overline{\text{OE}}$ Hold Time from $\overline{\text{WE}}$	7	-	8	-	ns	
41	t _{OE$\overline{\text{P}}$}	$\overline{\text{OE}}$ High Pulse Width	5	-	5	-	ns	
42	t _{PC}	Read or Write Cycle Time (EDO Page)	18	-	20	-	ns	14
43	t _{CPA}	Access Time from $\overline{\text{CAS}}$ Precharge (EDO Page)	-	21	-	23	ns	13
44	t _{CP}	$\overline{\text{CAS}}$ Precharge Time	7	-	8	-	ns	
45	t _{PCM}	EDO Page Mode RMW Cycle Time	46	-	50	-	ns	
46	t _{CRW}	EDO Page Mode $\overline{\text{CAS}}$ Pulse Width (RMW)	35	-	38	-	ns	
47	t _{RASP}	$\overline{\text{RAS}}$ Pulse Width (EDO Page)	45	200K	50	200K	ns	
48	t _{CSR}	$\overline{\text{CAS}}$ Setup Time ($\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$)	5	-	5	-	ns	3
49	t _{CHR}	$\overline{\text{CAS}}$ Hold Time ($\overline{\text{CAS}}$ -before- $\overline{\text{RAS}}$)	10	-	10	-	ns	3
50	t _{RPC}	$\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ Precharge Time	10	-	10	-	ns	3
51	t _{OE$\overline{\text{Z}}$}	Output Buffer Turn-off Delay from $\overline{\text{OE}}$	-	2	-	3	ns	8
52	t _{RASS}	$\overline{\text{RAS}}$ pulse width ($\overline{\text{C}}$ -B- $\overline{\text{R}}$ self refresh)	100	-	100	-	μs	
53	t _{RPS}	$\overline{\text{RAS}}$ precharge time ($\overline{\text{C}}$ -B- $\overline{\text{R}}$ self refresh)	76	-	84	-	ns	
54	t _{CHS}	$\overline{\text{CAS}}$ hold time ($\overline{\text{C}}$ -B- $\overline{\text{R}}$ self refresh)	-50	-	-50	-	ns	

**Notes:**

1. I_{CC1} , I_{CC3} , I_{CC4} , and I_{CC5} depend on cycle rate.
2. I_{CC1} and I_{CC4} depend on output loading. Specified values are obtained with the outputs open.
3. An initial pause of 200 μ s is required after power-up followed by any 8 $\overline{RAS}$ cycles before proper device operation is achieved. In the case of an internal refresh counter, a minimum of 8 $\overline{CAS}$ -before- $\overline{RAS}$ initialization cycles instead of 8 $\overline{RAS}$ cycles are required. 8 initialization cycles are required after extended periods of bias without clocks.
4. AC Characteristics assume $t_r = 2$ ns. All AC parameters are measured with a load equivalent to two TTL loads and 50pF, $V_{IL}(\text{min.}) \geq \text{GND}$ and $V_{IH}(\text{max.}) \leq V_{CC}$.
5. $V_{IH}(\text{min.})$ and $V_{IL}(\text{max.})$ are reference levels for measuring timing of input signals. Transition times are measured between V_{IH} and V_{IL} .
6. Operation within the $t_{RCO}(\text{max.})$ limit insures that $t_{RAC}(\text{max.})$ can be met. $t_{RCO}(\text{max.})$ is specified as a reference point only. If t_{RCO} is greater than the specified $t_{RCO}(\text{max.})$ limit, then access time is controlled exclusively by t_{CAC} .
7. Operation within the $t_{RAD}(\text{max.})$ limit insures that $t_{RAC}(\text{max.})$ can be met. $t_{RAD}(\text{max.})$ is specified as a reference point only. If t_{RAD} is greater than the specified $t_{RAD}(\text{max.})$ limit, then access time is controlled exclusively by t_{AA} .
8. Assumes three state test load (5pF and a 500 Ω Thevenin equivalent).
9. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
10. $t_{OFF}(\text{max.})$ defines the time at which the output achieves the open circuit condition; it is not referenced to output voltage levels.
11. t_{WCS} , t_{WCH} , t_{RWD} , t_{CWD} and t_{AWD} are not restrictive operating parameters. They are included in the data sheet as electrical characteristics only. If $t_{WCS} \geq t_{WCS}(\text{min.})$ and $t_{WCH} \geq t_{WCH}(\text{min.})$, the cycle is an early write cycle and data-out pins will remain open circuit, high impedance, throughout the entire cycle. If $t_{RWD} \geq t_{RWD}(\text{min.})$, $t_{CWD} \geq t_{CWD}(\text{min.})$ and $t_{AWD} \geq t_{AWD}(\text{min.})$, the cycle is a read-modify-write cycle and the data out will contain data read from the selected cell. If neither of the above conditions is satisfied, the condition of the data out at access time is indeterminate.
12. These parameters are referenced to $\overline{UCAS}$ and $\overline{LCAS}$ leading edge in early write cycles and to $\overline{WE}$ leading edge in read-modify-write cycles.
13. Access time is determined by the longer of t_{AA} or t_{CAC} or t_{CPA} .
14. $t_{ASC} \geq t_{CP}$ to achieve $t_{PC}(\text{min.})$ and $t_{CPA}(\text{max.})$ values.

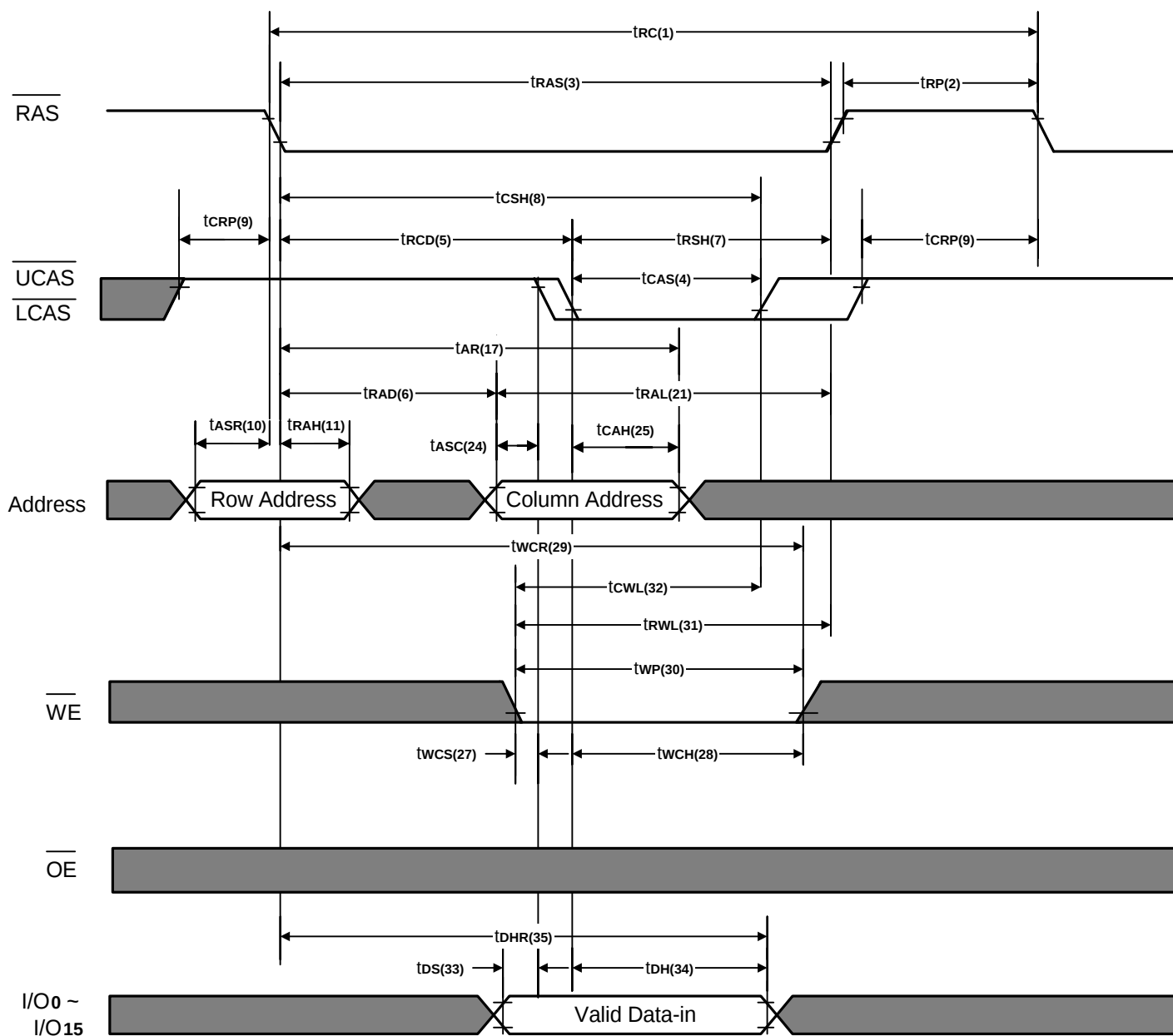


Word Read Cycle

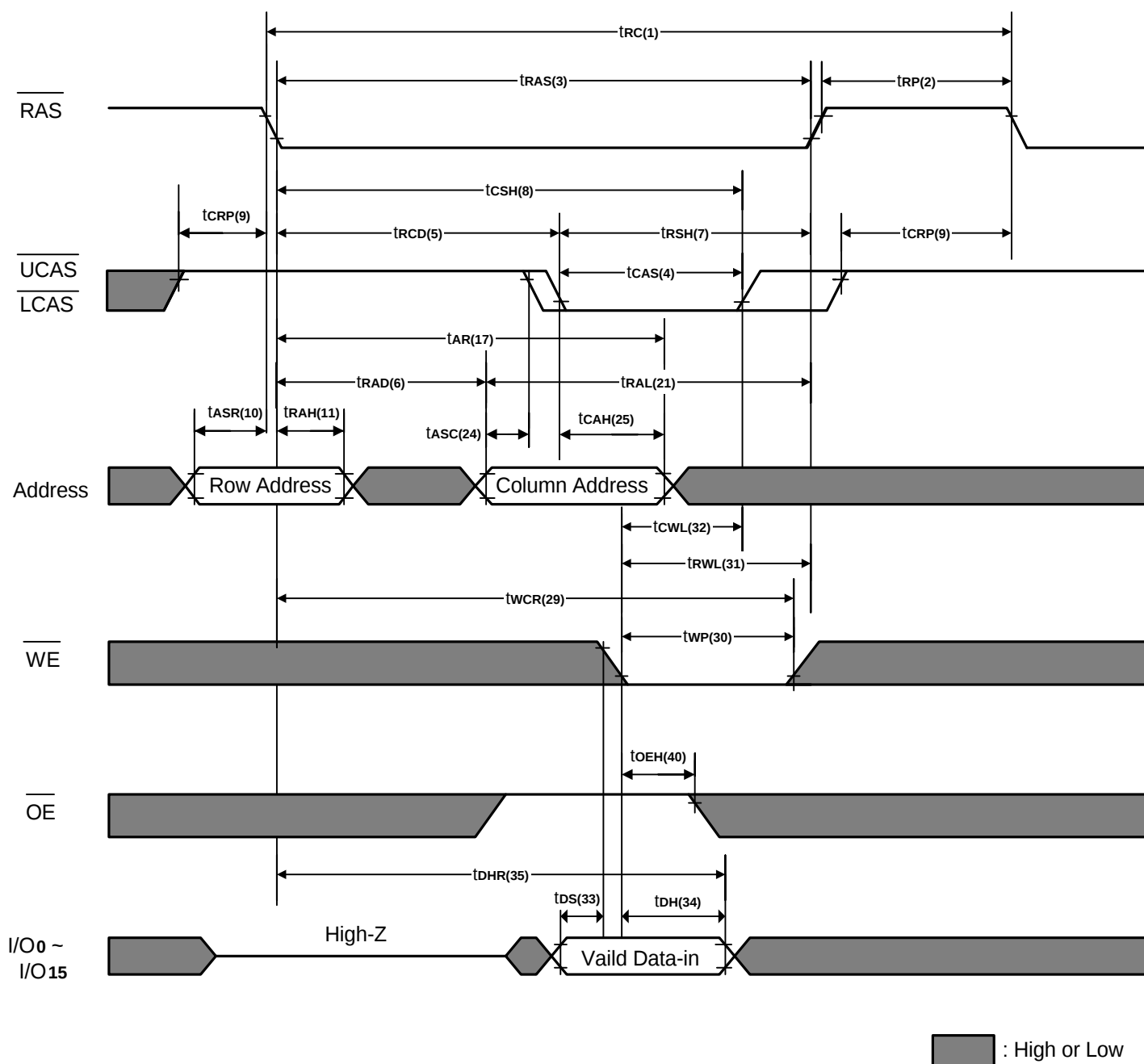


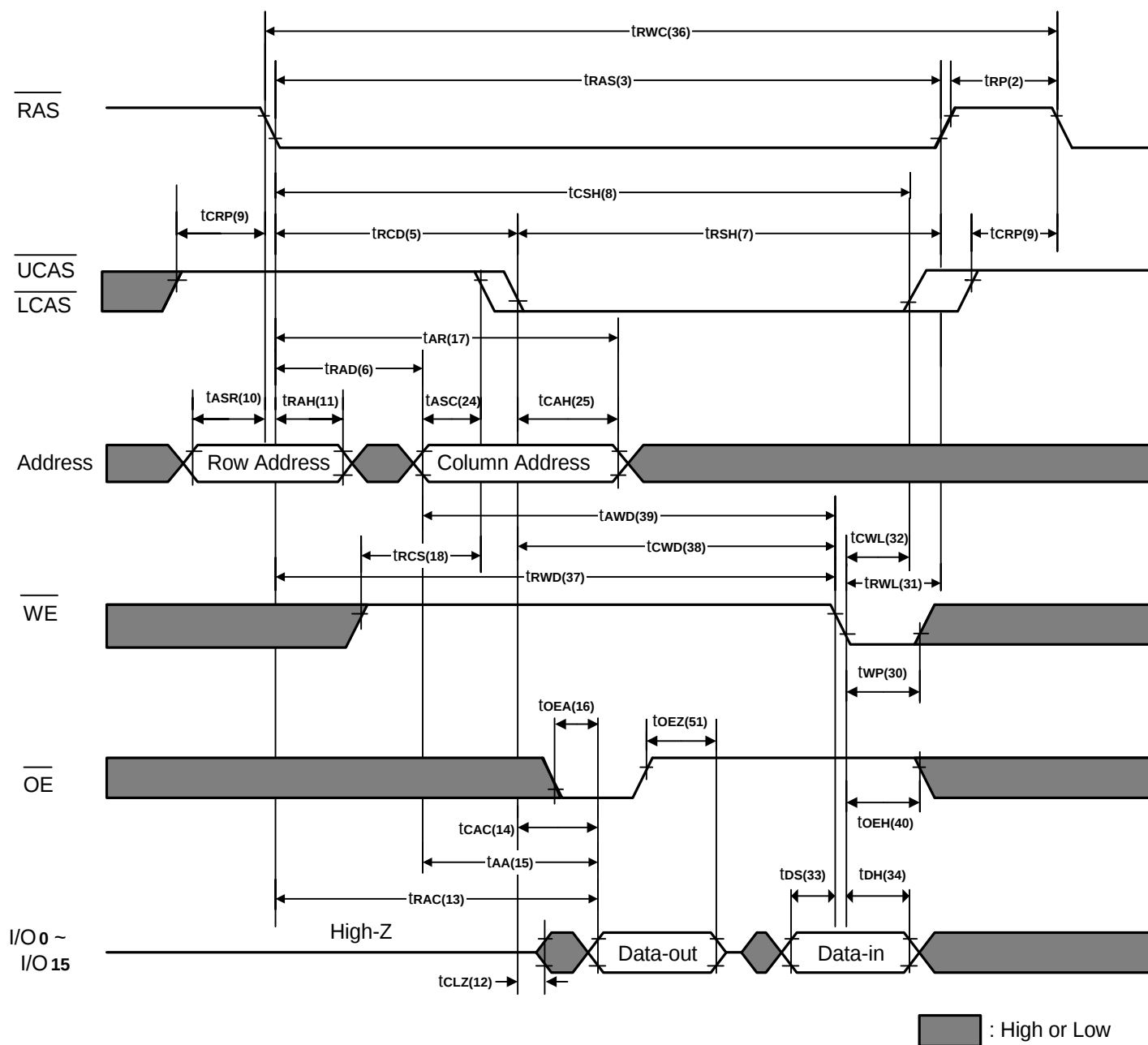


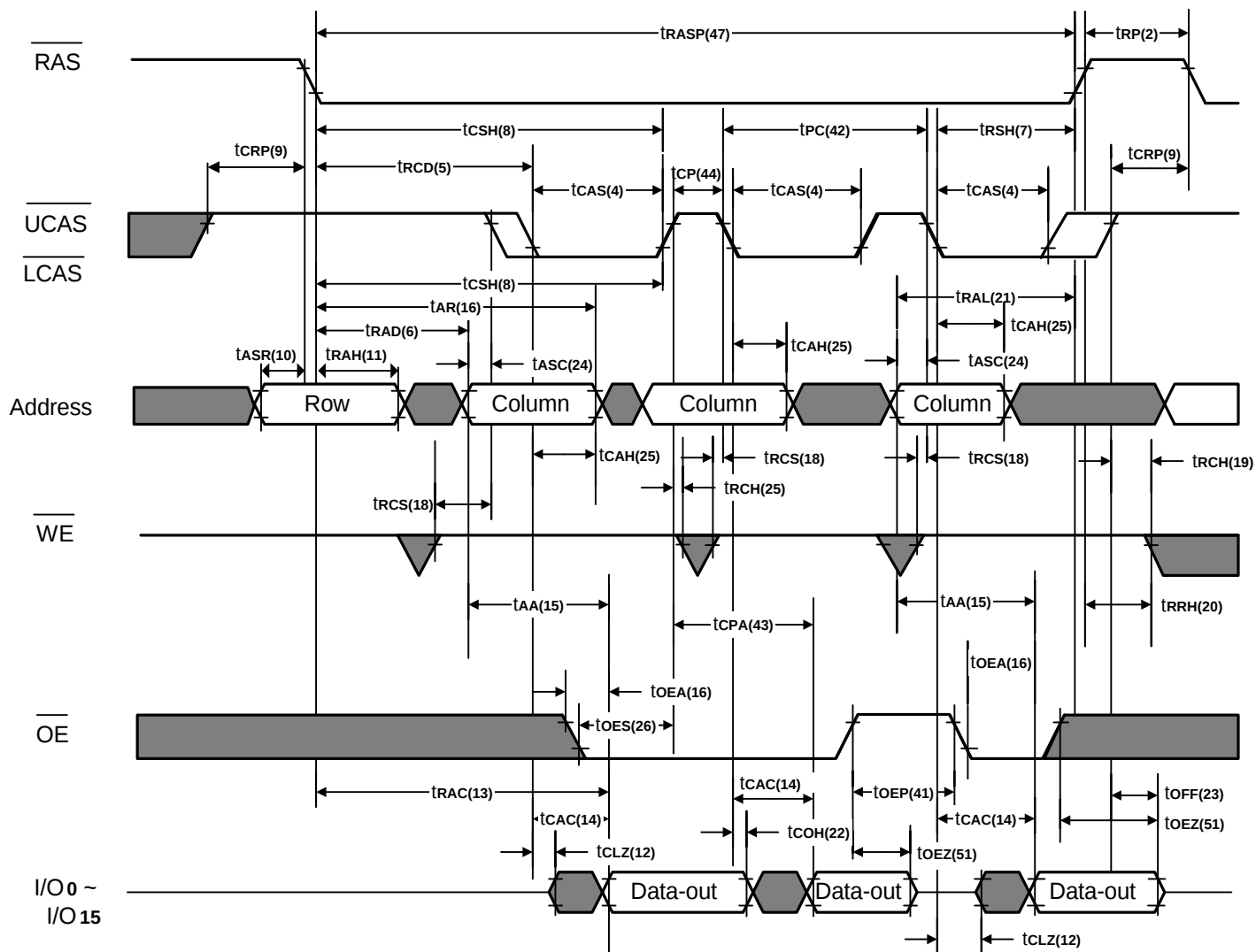
Word Write Cycle (Early Write)



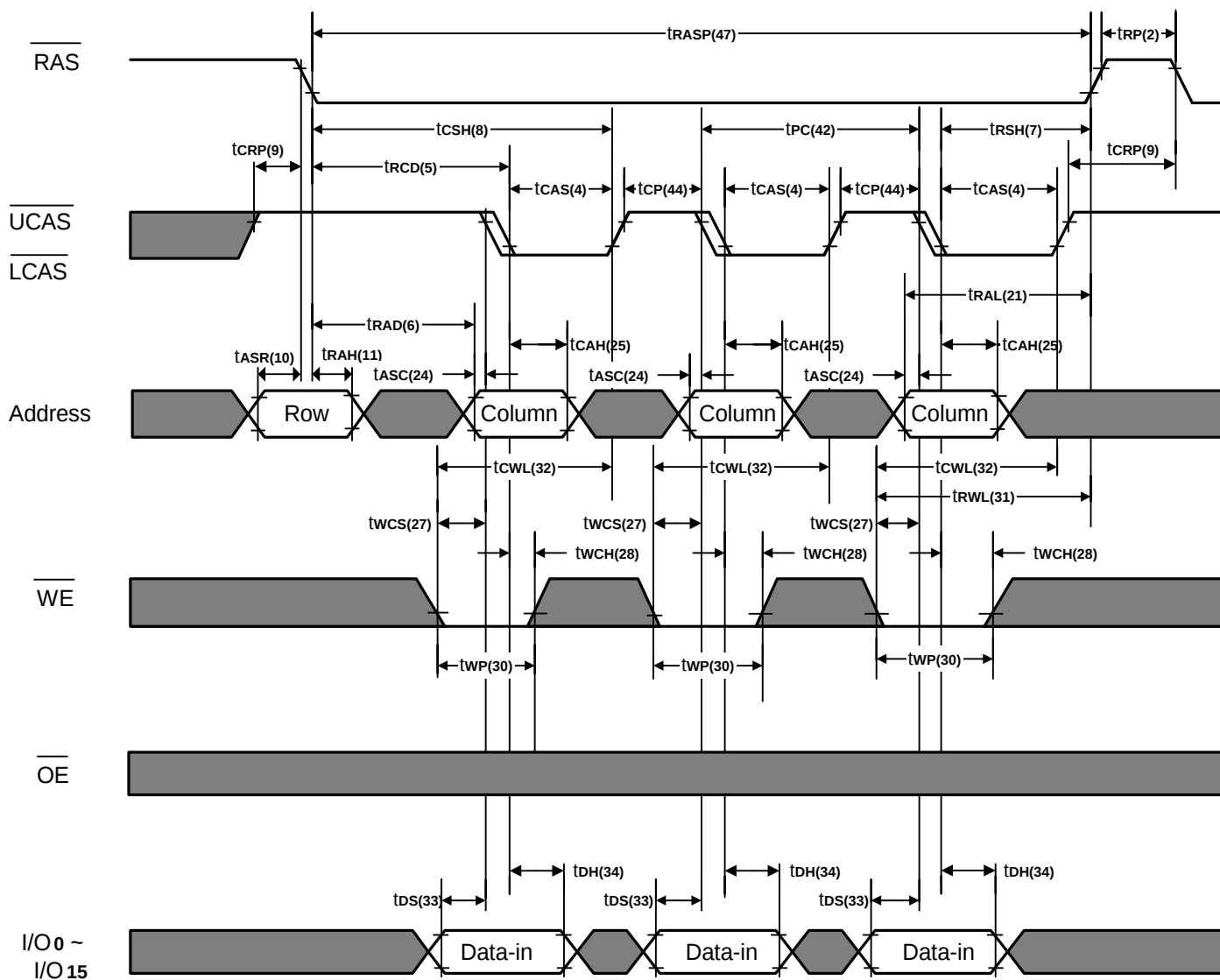
: High or Low

Word Write Cycle (Late Write)


Word Read-Modify-Write Cycle


EDO Page Mode Word Read Cycle


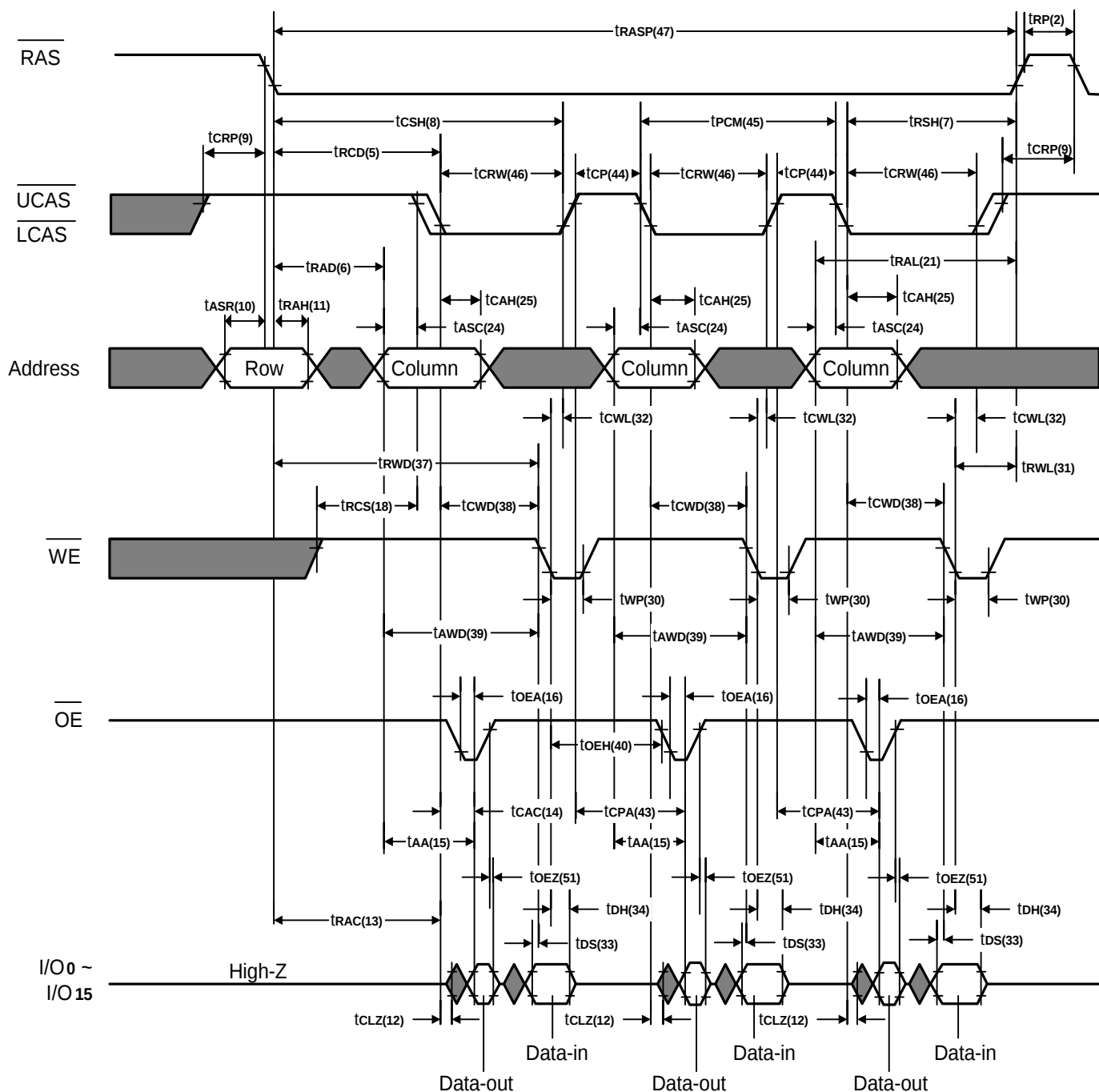
 : High or Low

EDO Page Mode Early Word Write Cycle


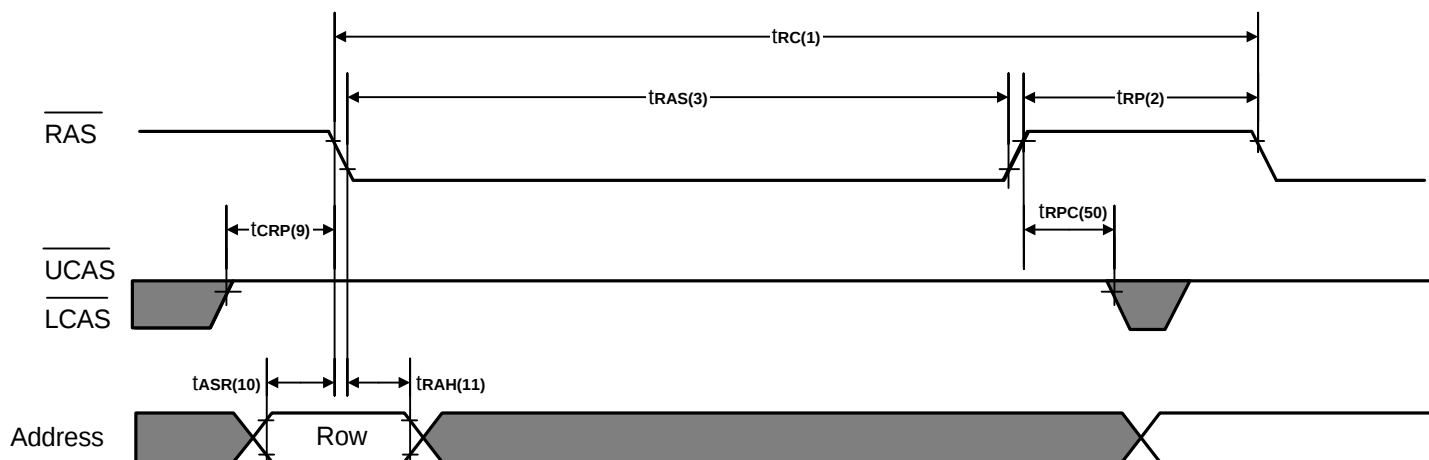
 : High or Low



EDO Page Mode Word Read-Modify-Write Cycle

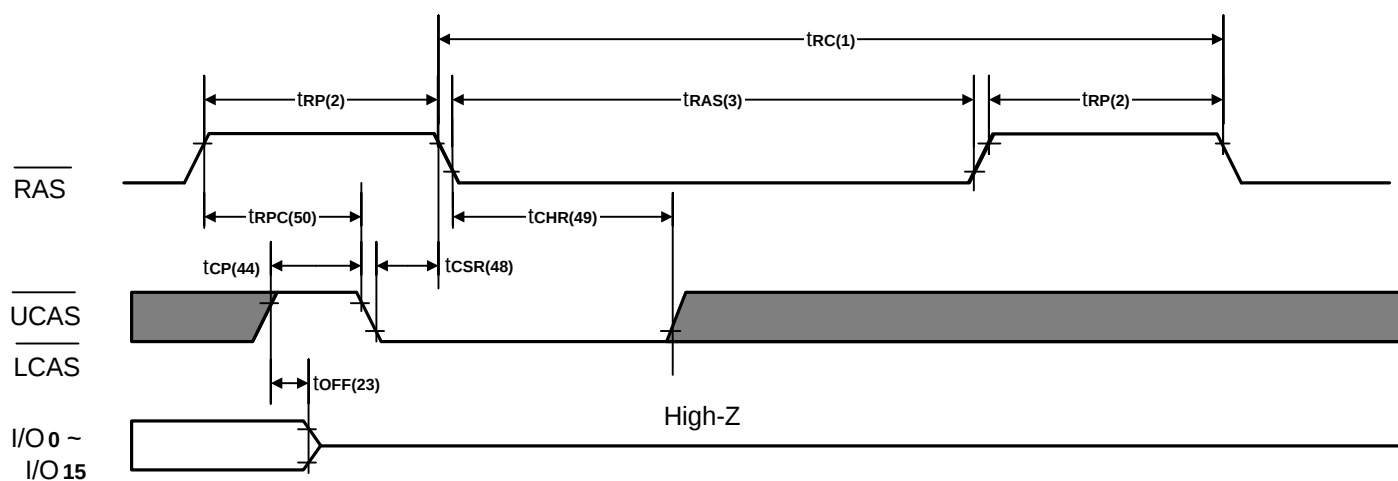


: High or Low

**RAS Only Refresh Cycle**

Note: $\overline{WE}$, $\overline{OE}$ = Don't care.

 : High or Low

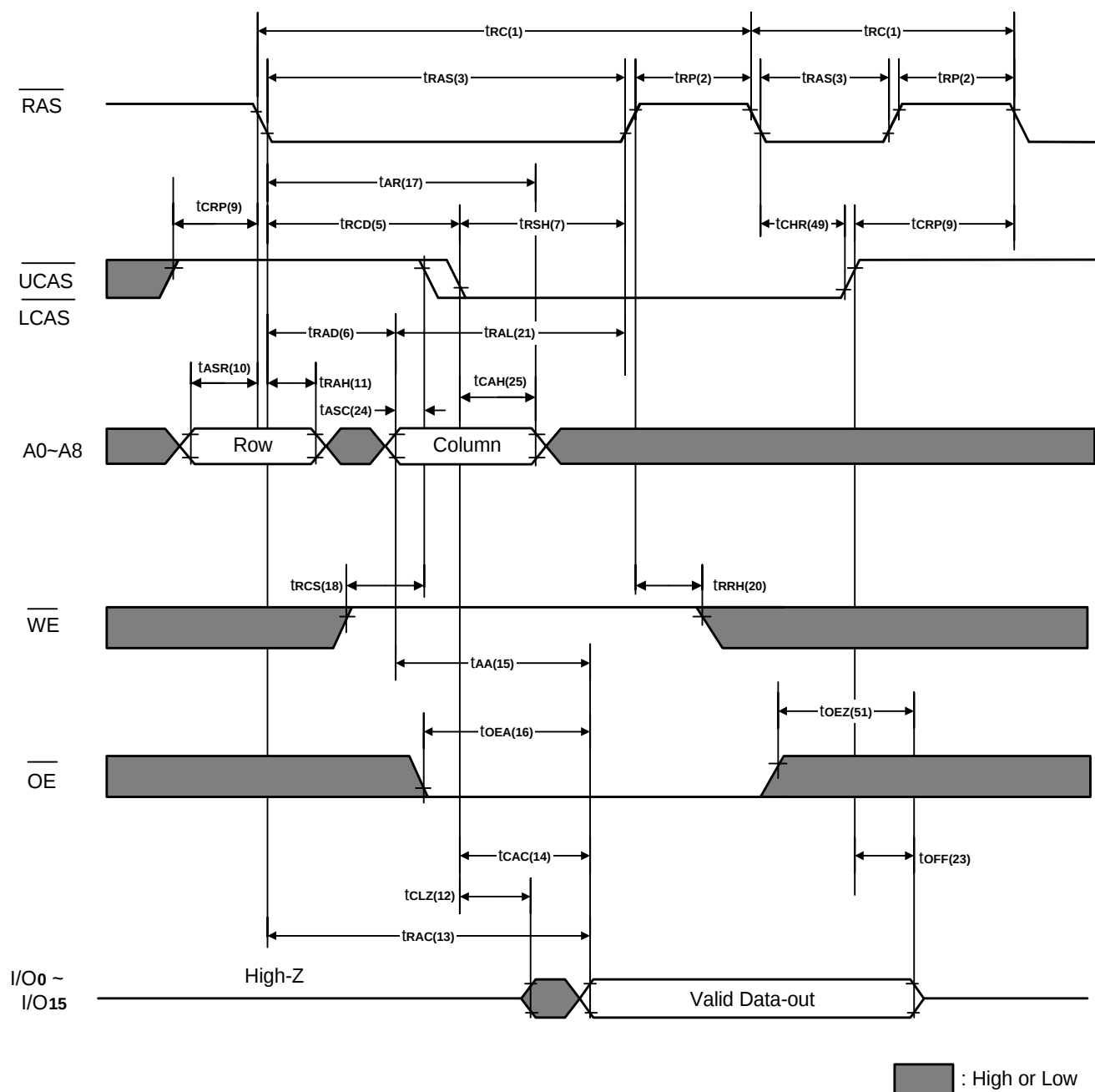
CAS Before RAS Refresh Cycle

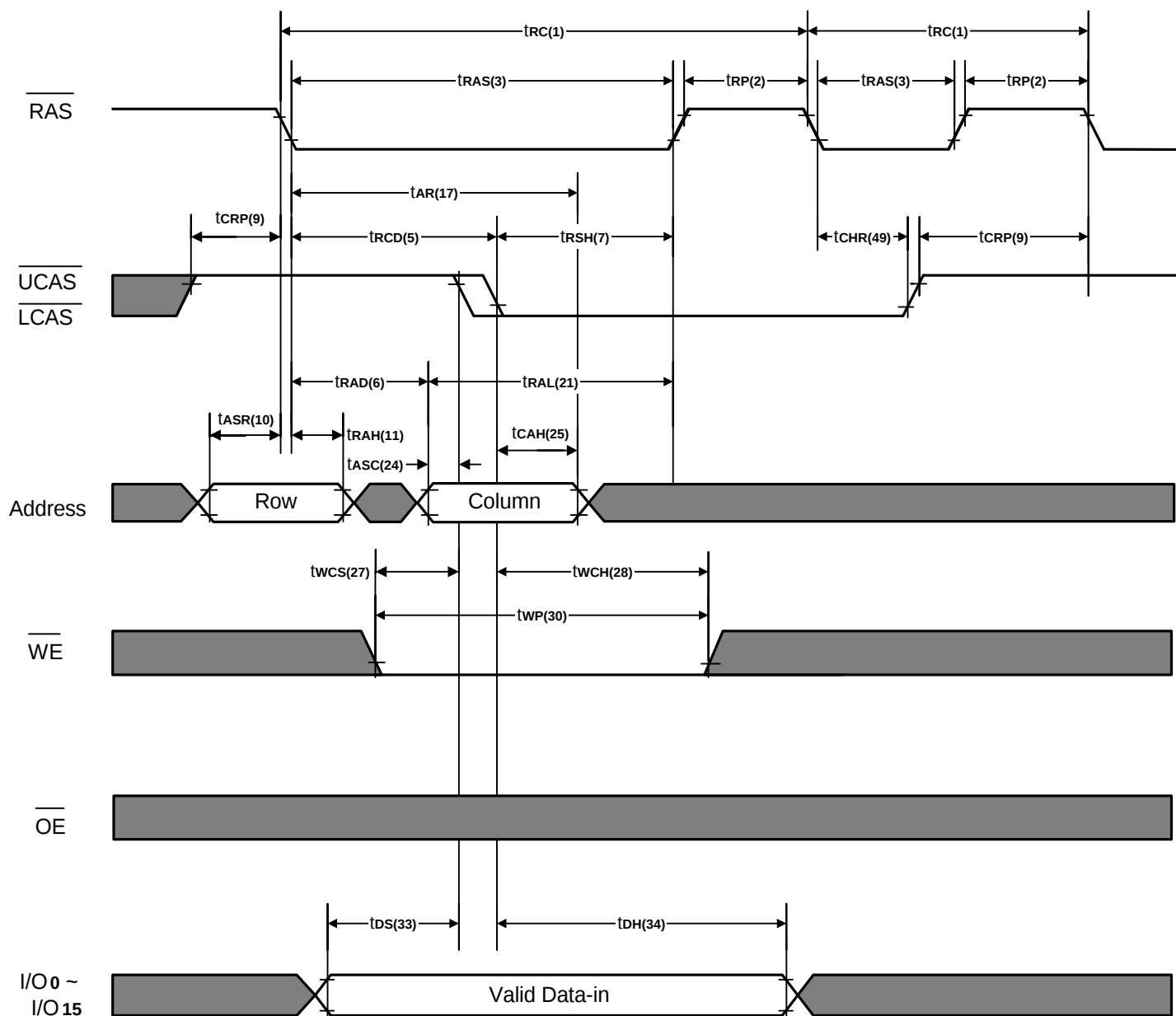
Note: $\overline{WE}$, $\overline{OE}$, Address = Don't care.

 : High or Low



Hidden Refresh Cycle (Word Read)

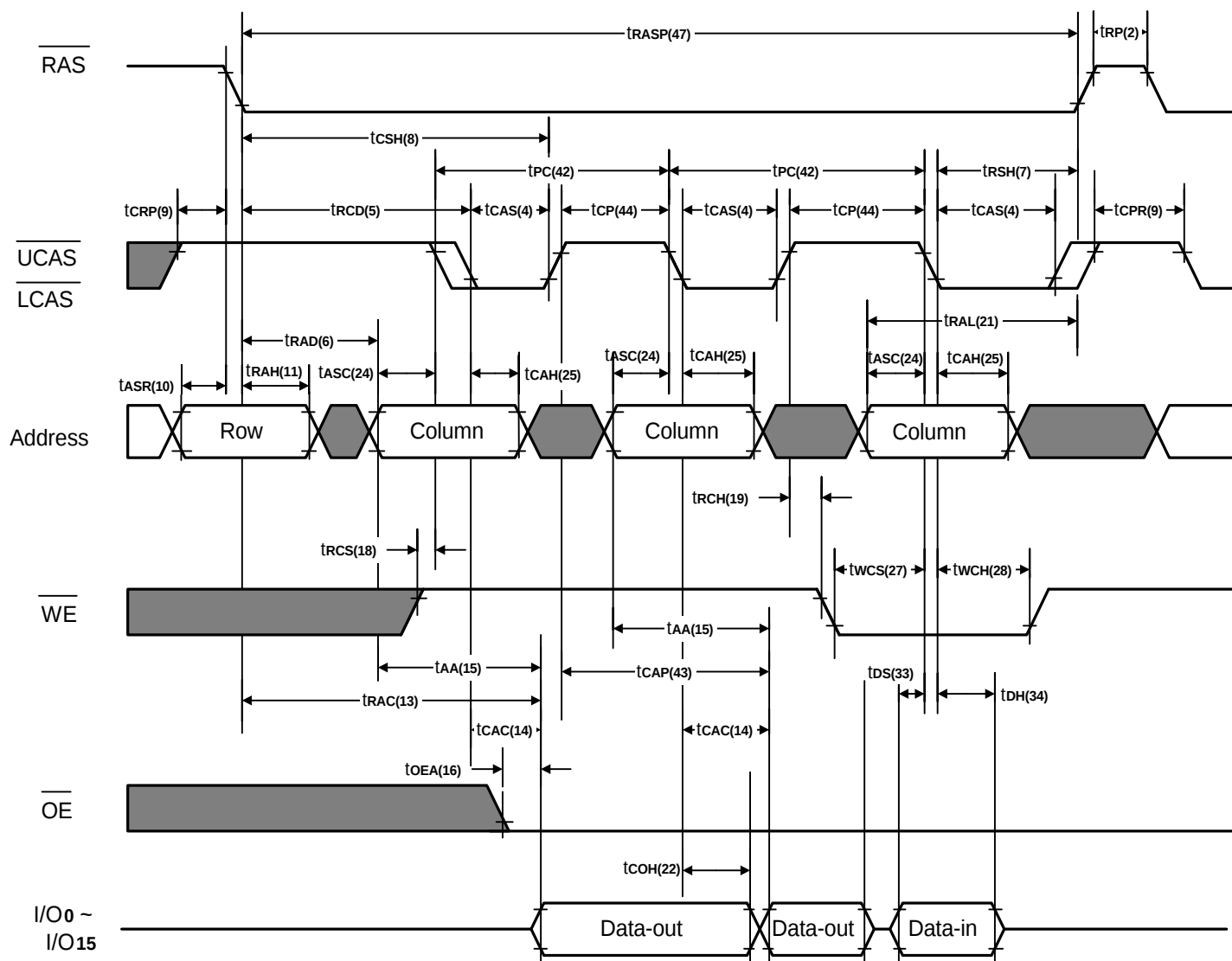


Hidden Refresh Cycle (Early Word Write)


 : High or Low

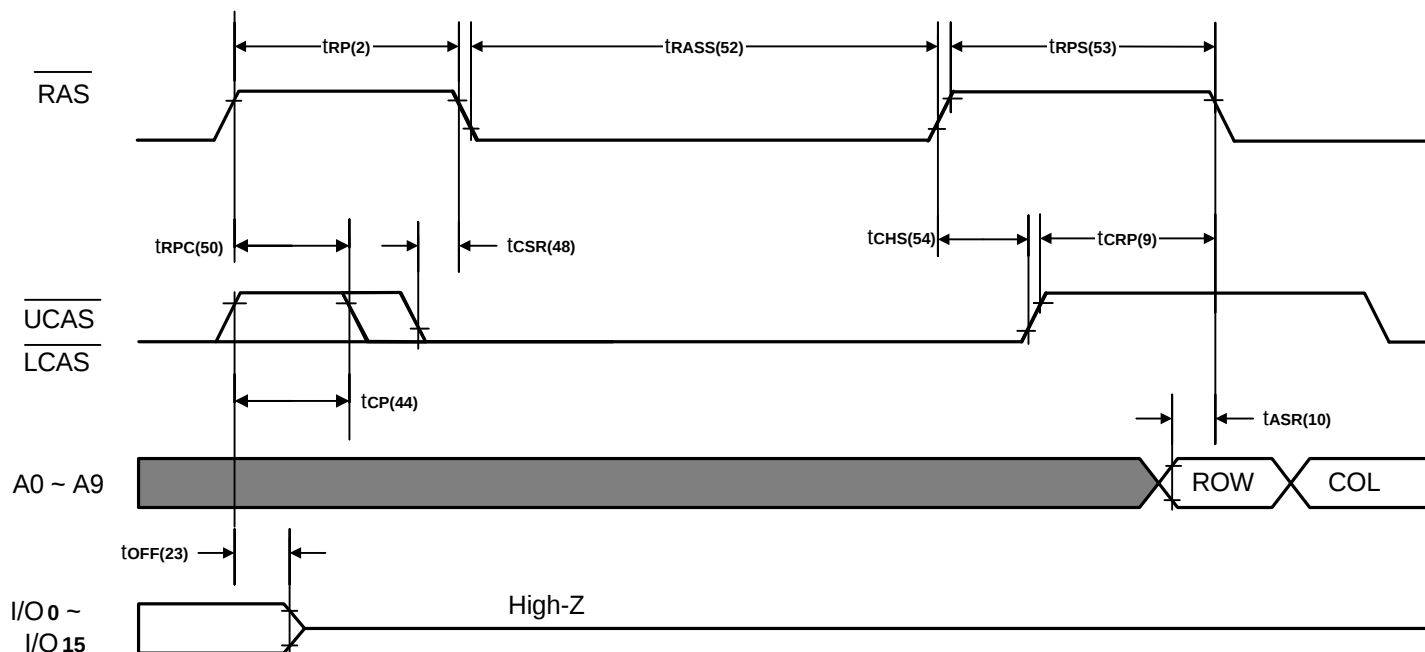


EDO Page Mode Read-Early-Write Cycle (Pseudo Read-Modify-Write)



: High or Low

Self Refresh Mode



Note: $\overline{WE}$, $\overline{OE}$ = Don't care.

 : High or Low

■ Self Refresh Mode.

a. Entering the Self Refresh Mode:

The A420616 Self Refresh Mode is entered by using $\overline{CAS}$ before $\overline{RAS}$ cycle and holding $\overline{RAS}$ and $\overline{CAS}$ signal "low" longer than 100 μ s.

b. Continuing the Self Refresh Mode:

The Self Refresh Mode is continued by holding $\overline{RAS}$ "low" after entering the Self Refresh Mode.

It does not depend on $\overline{CAS}$ being "high" or "low" after entering the Self Refresh Mode continue the Self Refresh Mode.

c. Exiting the Self Refresh Mode:

The A420616 exits the Self Refresh Mode when the $\overline{RAS}$ signal is brought "high".



A420616 Series

Capacitance (f = 1MHz, Ta = Room Temperature, VCC = 5.0V ± 10%)

Symbol	Signals	Parameter	Max.	Unit	Test Conditions
C _{IN1}	A0 – A9	Input Capacitance	5	pF	V _{in} = 0V
C _{IN2}	$\overline{\text{RAS}}$, $\overline{\text{UCAS}}$, $\overline{\text{LCAS}}$, $\overline{\text{WE}}$, $\overline{\text{OE}}$		7	pF	V _{in} = 0V
C _{I/O}	I/O ₀ - I/O ₁₅	I/O Capacitance	7	pF	V _{in} = V _{out} = 0V

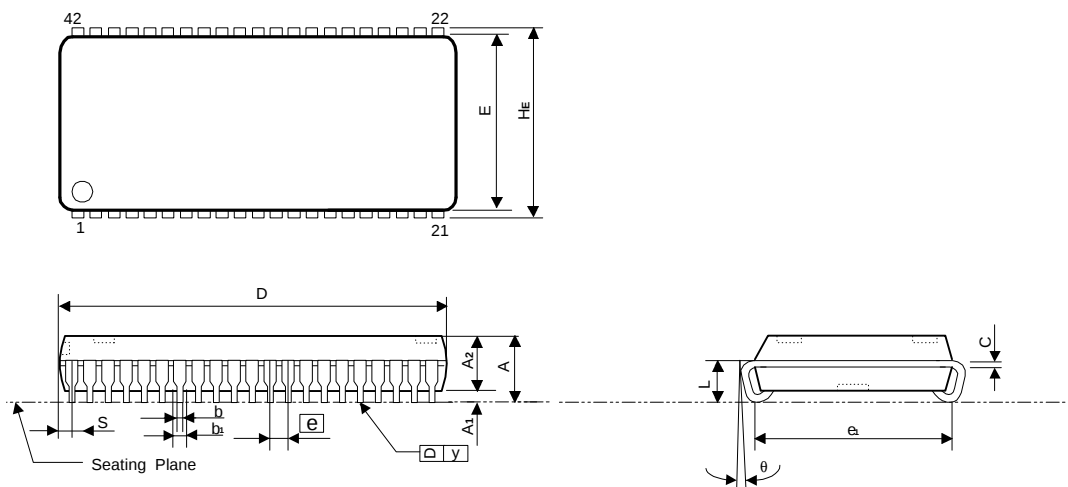
Ordering Codes

Package $\overline{\text{RAS}}$ Access Time	45ns	50ns	Refresh Cycle	Self-Refresh
SOJ 42L (400mil)	A420616S-45	A420616S-50	1K	Yes
TSOP 44/50L type II (400mil)	A420616V-45	A420616V-50	1K	Yes
TSOP 44/50L type II (400mil)	A420616V-45U	A420616V-50U	1K	Yes

Note: -U is for industrial operating temperature range.

Package Information
SOJ 42L Outline Dimensions

unit: inches/mm



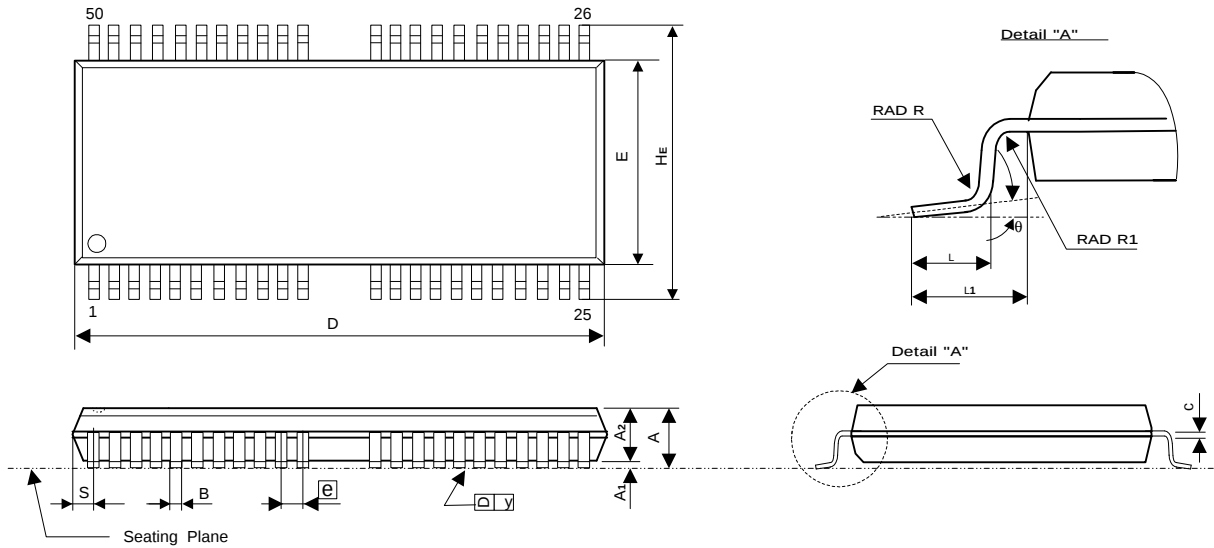
Symbol	Dimensions in inches			Dimensions in mm		
	Min	Nom	Max	Min	Nom	Max
A	0.132	0.138	0.145	3.35	3.51	3.68
A1	0.025	-	-	0.64	-	-
A2	0.105	0.110	0.115	2.67	2.79	2.92
b1	0.026	0.028	0.032	0.66	0.71	0.81
b	0.016	0.018	0.020	0.41	0.46	0.51
C	0.007	0.008	0.011	0.18	0.20	0.28
D	1.070	1.075	1.080	27.18	27.31	27.43
E	0.395	0.400	0.405	10.03	10.16	10.29
e	-	0.050	-	-	1.27	-
e1	0.360	0.370	0.380	9.14	9.40	9.65
HE	0.435	0.440	0.455	11.05	11.18	11.30
L	0.088	-	-	2.24	-	-
S	-	-	0.043	-	-	1.09
y	-	-	0.004	-	-	0.10
θ	0°	-	10°	0°	-	10°

2Notes:

1. The maximum value of dimension D includes end flash.
2. Dimension E does not include resin fins.
3. Dimension e1 is for PC Board surface mount pad pitch design reference only.
4. Dimension S includes end flash.

Package Information
TSOP 44/50L (Type II) Outline Dimensions

unit: inches/mm



Symbol	Dimensions in inches			Dimensions in mm		
	Min	Nom	Max	Min	Nom	Max
A	-	-	0.048	-	-	1.20
A1	0.002	-	0.006	0.05	-	0.15
A2	0.037	0.039	0.042	0.95	1.00	1.05
B	0.012	-	0.018	0.30	-	0.45
c	0.005	-	0.008	0.12	-	0.21
D	0.820	0.825	0.830	20.82	20.95	21.08
E	0.400 BSC			10.16 BSC		
HE	0.463 BSC			11.76 BSC		
L	0.016	0.020	0.024	0.40	0.50	0.60
L1	0.031 REF			0.80 REF		
[e]	0.031 BSC			0.80 BSC		
R	0.005	-	0.010	0.12	-	0.25
R1	0.005	-	-	0.12	-	-
S	0.0435 REF			0.875 BSC		
θ	0°	-	5°	0°	-	5°

Notes:

1. The maximum value of dimension D includes end flash.
2. Dimension E does not include resin fins.
3. Dimension S includes end flash.